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Unit: mm

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSV)

2SK3445

Switching Regulator, DC-DC Converter Applications Motor Drive Applications

- Low drain-source ON resistance: $RDS(ON) = 90 \text{ m}\Omega \text{ (typ.)}$
- High forward transfer admittance: $|Y_{fs}| = 10 \text{ S (typ.)}$
- Low leakage current: $I_{DSS} = 100 \mu A (V_{DS} = 250 \text{ V})$
- Enhancement mode: $V_{th} = 3.0 \text{ to } 5.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	250	V	
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V_{DGR}	250	V	
Gate-source voltage	е	V _{GSS}	±30	V	
Drain current	DC (Note 1)	I _D	20	А	
Diam current	Pulse (Note 1) I _{DP} 80	80			
Drain power dissipation (Tc = 25°C)		PD	125	W	
Single pulse avalanche energy (Note 2)		E _{AS}	487	mJ	
Avalanche current		I _{AR}	20	Α	
Repetitive avalanche energy (Note 3)		E _{AR}	12.5	mJ	
Channel temperatu	re	T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

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Weight: 0.74 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	1.00	°C/W

Notice:

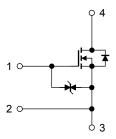
Please use the S1 pin for gate input signal return. Make sure that the main current flows into the S2 pin.

Note 1: Ensure that the channel temperature does not exceed 150°C.

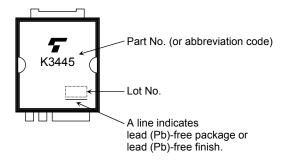
Note 2: $V_{DD} = 50$ V, $T_{ch} = 25$ °C (initial), L = 2.06 mH, $I_{AR} = 20$ A, $R_G = 25$ Ω

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Please handle with caution.



Marking



Electrical Characteristics (Note 4) (Ta = 25°C)

	Characteristics Gate leakage current		Symbol	Test Condition	Min	Тур.	Max	Unit	
			I _{GSS}	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μΑ	
www.Date	Data Draintcut-off current	ent	I _{DSS}	V _{DS} = 250 V, V _{GS} = 0 V	_	_	100	μА	
	Drain-source brea	akdown voltage	V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	250	_	_	V	
	Gate threshold vo	oltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	3.0	_	5.0	V	
	Drain-source ON resistance Forward transfer admittance Input capacitance Reverse transfer capacitance Output capacitance	R _{DS} (ON)	V _{GS} = 10 V, I _D = 10 A	_	90	105	mΩ		
		admittance	Y _{fs}	$V_{DS} = 10 \text{ V}, I_D = 10 \text{ A}$	5	10		S	
)	C _{iss}		_	2090			
		C _{rss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	280		pF		
		Coss		_	1000				
	Switching time Rise time Turn-on time Fall time	t _r	$V_{GS} \stackrel{10}{\underset{0}{\text{ V}}} \int \int I_{D} = 10 \text{ A}$	_	20				
		Turn-on time	t _{on}			40		- ns	
		Fall time	t _f	C. 7.7.2		10			
		Turn-off time	t _{off}	Duty \leq 1%, $t_W = 10 \mu s$ $V_{DD} \simeq 125 V$		40			
	Total gate charge (gate-source plus		Qg	V _{DD} ≈ 200 V, V _{GS} = 10 V,	_	45	_		
Gate-s	Gate-source char	Sate-source charge		I _D = 20 A	_	22	_	nC	
	Gate-drain ("miller") charge		Q _{gd}		_	23	_		

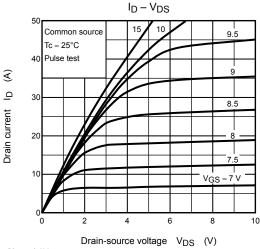
Note 4: Connect the S1 pin and S2 pin together, then ground them except during switching time measurement.

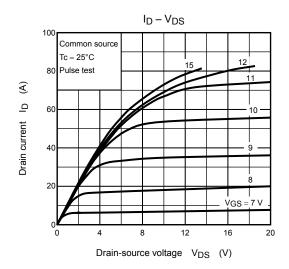
Source-Drain Ratings and Characteristics (Note 5) (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1, Note 5)	I _{DR} 1	_	_	_	20	Α
Pulse drain reverse current (Note 1, Note 5)	I _{DRP} 1	_	_	_	80	Α
Continuous drain reverse current (Note 1, Note 5)	I _{DR} 2	_	_	_	1	Α
Pulse drain reverse current (Note 1, Note 5)	I _{DRP} 2	_	_	_	4	Α
Forward voltage (diode)	V _{DS2F}	I _{DR1} = 20 A, V _{GS} = 0 V	_	_	-1.5	V
Reverse recovery time	t _{rr}	$I_{DR} = 20 \text{ A}, V_{GS} = 0 \text{ V}, \\ dI_{DR}/dt = 100 \text{ A/}\mu\text{s}$	_	320	_	ns
Reverse recovery charge	Q _{rr}		_	2.8	_	μС

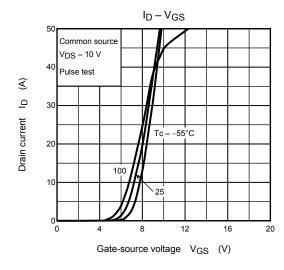
Note 5: I_{DR}1, I_{DRP}1: Current flowing between the drain and the S2 pin. Ensure that the S1 pin is left open. I_{DR}2, I_{DRP}2: Current flowing between the drain and the S1 pin. Ensure that the S2 pin is left open.

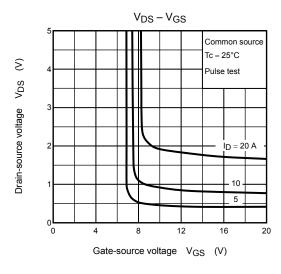
Unless otherwise specified, connect the S1 and S2 pins together, and ground them.

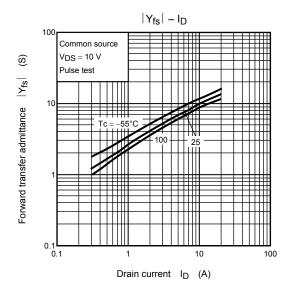


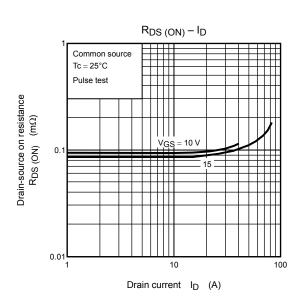


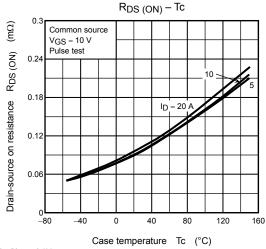
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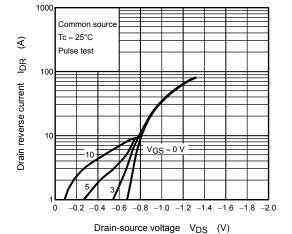






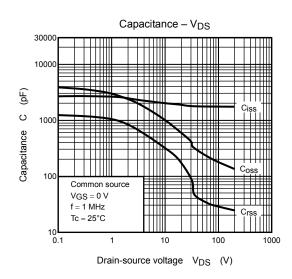


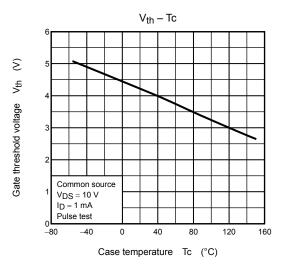


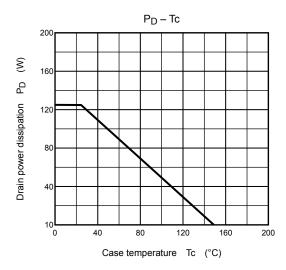


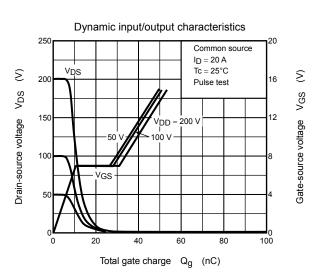
 $I_{DR} - V_{DS}$

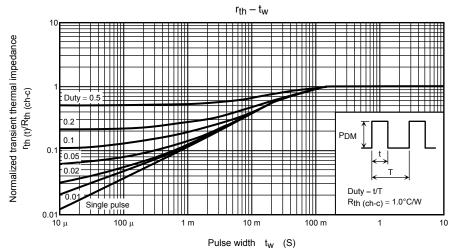
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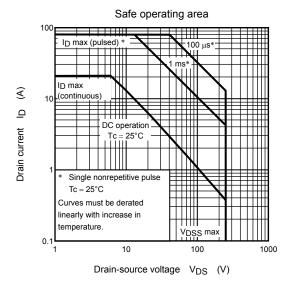


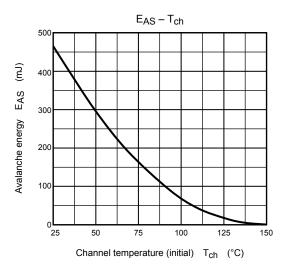


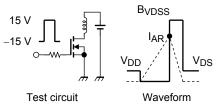




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$$\begin{aligned} &R_G = 25~\Omega \\ &V_{DD} = 50~V,~L = 2.06~mH \end{aligned} \qquad EAS = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{BVDSS}{BVDSS - V_{DD}} \right)$$

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